

FDS2070N7

150V N-Channel PowerTrench[®] MOSFET

General Description

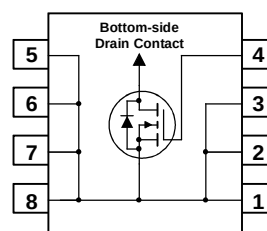
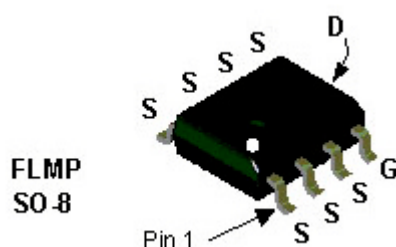
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

Applications

- Synchronous rectifier
- DC/DC converter

Features

- 4.1 A, 150 V. $R_{DS(ON)} = 78 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
 $R_{DS(ON)} = 88 \text{ m}\Omega @ V_{GS} = 6.0 \text{ V}$
- High performance trench technology for extremely low $R_{DS(ON)}$
- High power and current handling capability
- Fast switching, low gate charge (38nC typical)
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size



Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DSS}	Drain-Source Voltage	150	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Drain Current – Continuous (Note 1a)	4.1	A
	– Pulsed	30	
P_D	Power Dissipation for Single Operation (Note 1a)	3.0	W
	(Note 1b)	1.8	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to $+150$	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	40	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	0.5	

Package Marking and Ordering Information

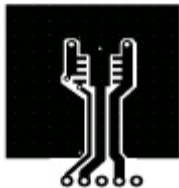
Device Marking	Device	Reel Size	Tape width	Quantity
FDS2070N7	FDS2070N7	13"	12mm	2500 units

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Drain-Source Avalanche Ratings						
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, V _{DD} = 150 V, I _D = 10 A L = 8.8 mH			440	mJ
I _{AR}	Drain-Source Avalanche Current				10	A
Off Characteristics						
BV _{DSS}	Drain–Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	150			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		154		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate–Body Leakage	V _{GS} = ± 20 V, V _{DS} = 0 V			±100	nA
On Characteristics (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2	2.6	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		–7		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	V _{GS} = 10 V, I _D = 4.1 A V _{GS} = 6.0V, I _D = 3.8 A V _{GS} = 10 V, I _D = 4.1 A, T _J = 125°C		57 60 111	78 88 160	mΩ
g _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 4.1 A		24		S
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, f = 1.0 MHz		1884		pF
C _{oss}	Output Capacitance			102		pF
C _{rss}	Reverse Transfer Capacitance			35		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		1.6		Ω
Switching Characteristics (Note 2)						
t _{d(on)}	Turn–On Delay Time	V _{DD} = 75 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω		10	20	ns
t _r	Turn–On Rise Time			6	12	ns
t _{d(off)}	Turn–Off Delay Time			40	64	ns
t _f	Turn–Off Fall Time			20	36	ns
Q _g	Total Gate Charge	V _{DS} = 75 V, I _D = 4.1 A, V _{GS} = 10 V		38	53	nC
Q _{gs}	Gate–Source Charge			8		nC
Q _{gd}	Gate–Drain Charge			11		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain–Source Diode Forward Current				2.5	A
V _{SD}	Drain–Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.5 A (Note 2)		0.75	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 4.1A		75		nS
Q _{rr}	Diode Reverse Recovery Charge	dI _F /dI _t = 100 A/μs (Note 2)		404		nC

Notes:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 40°C/W when mounted on a 1 in^2 pad of 2 oz copper

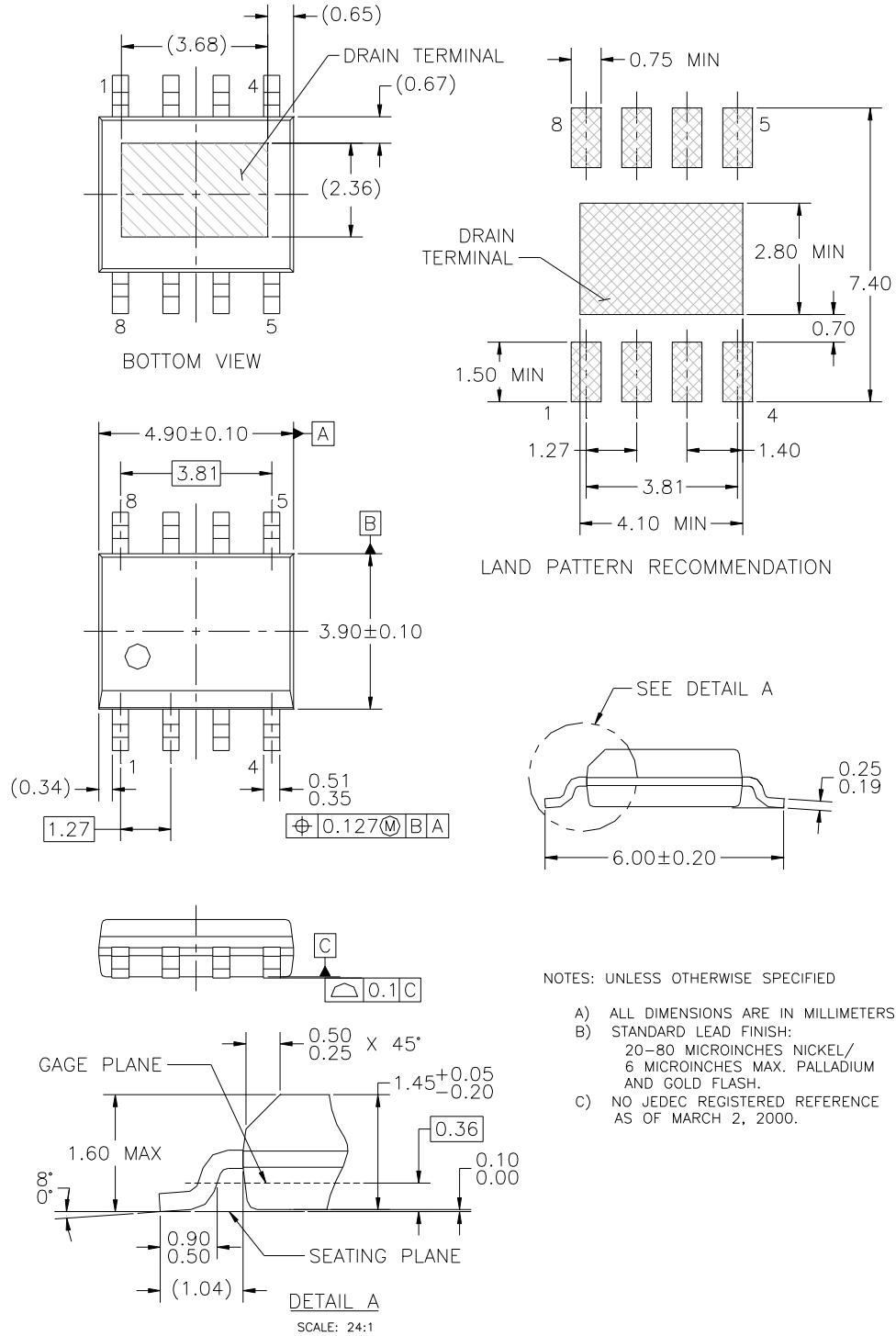


b) 85°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μs , Duty Cycle < 2.0%

Dimensional Outline and Pad Layout



Typical Characteristics

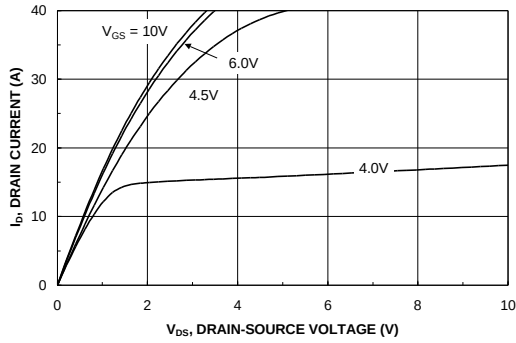


Figure 1. On-Region Characteristics.

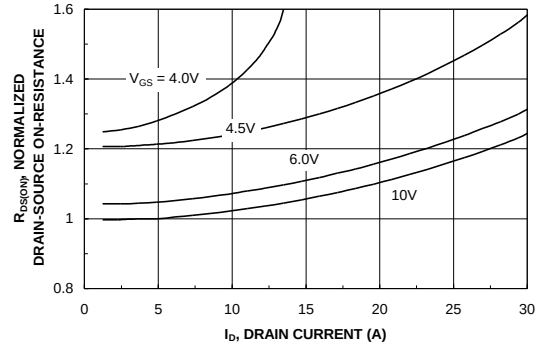


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

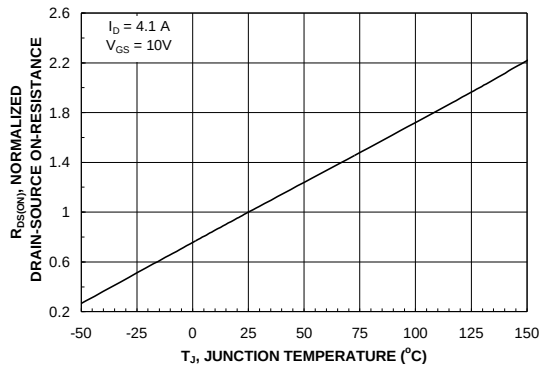


Figure 3. On-Resistance Variation with Temperature.

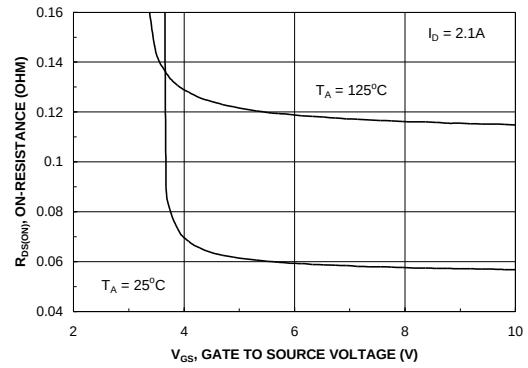


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

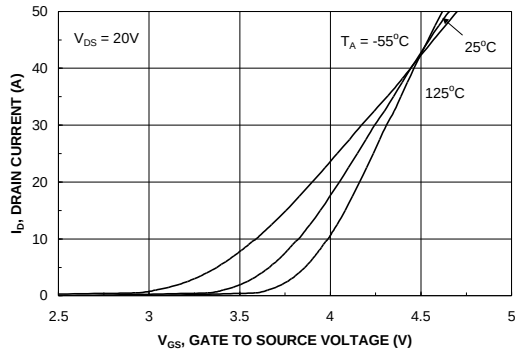


Figure 5. Transfer Characteristics.

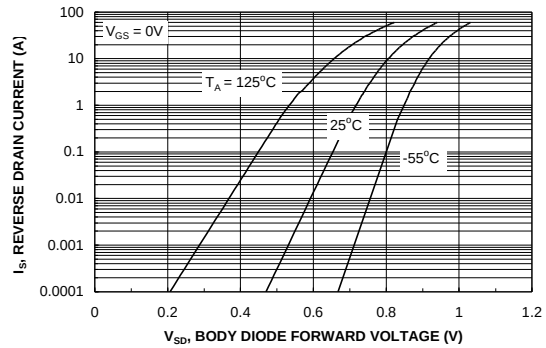


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics

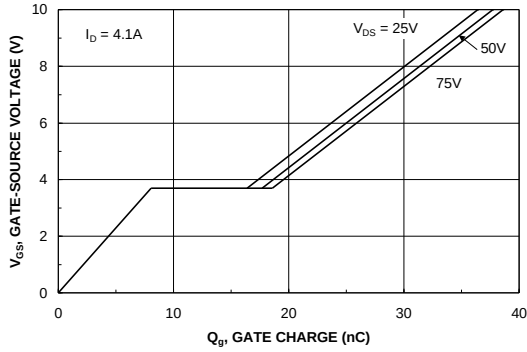


Figure 7. Gate Charge Characteristics.

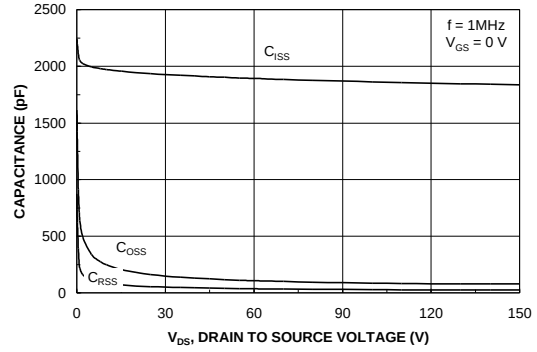


Figure 8. Capacitance Characteristics.

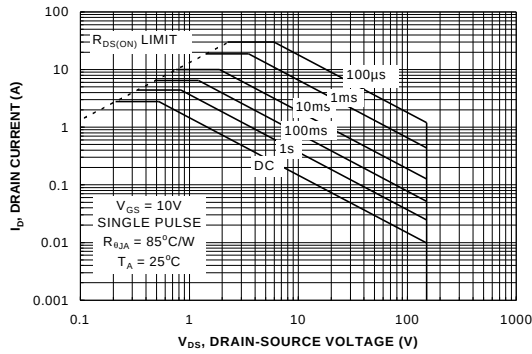


Figure 9. Maximum Safe Operating Area.

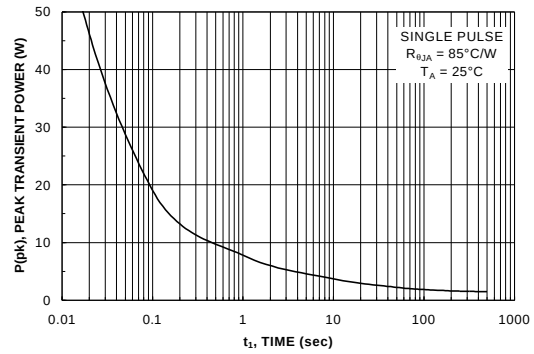


Figure 10. Single Pulse Maximum Power Dissipation.

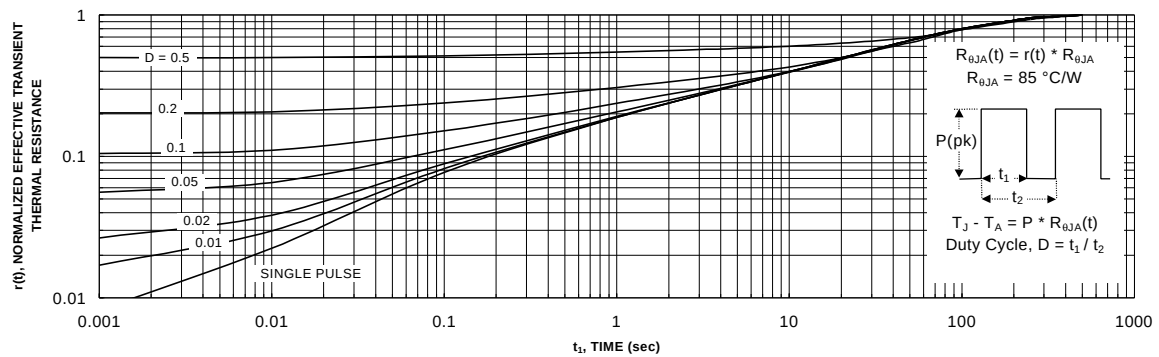


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b.
Transient thermal response will change depending on the circuit board design.

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